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With the principle of “Quality Parts,Customers Priority,Honest Operation,and Considerate Service”,our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip,ALPS,ROHM,Xilinx,Pulse,ON,Everlight and Freescale. Main products comprise IC,Modules,Potentiometer,IC Socket,Relay,Connector.Our parts cover such applications as commercial,industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



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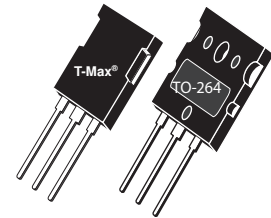
Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China



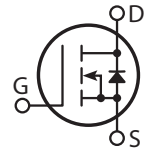
## Super Junction MOSFET

- Ultra Low  $R_{DS(ON)}$
- Low Miller Capacitance
- Ultra Low Gate Charge,  $Q_g$
- Avalanche Energy Rated
- Extreme  $dv/dt$  Rated

APT94N65B2C6



APT94N65LC6



Unless stated otherwise, Microsemi discrete MOSFETs contain a single MOSFET die. This device is made with two parallel MOSFET die. It is intended for switch-mode operation. It is not suitable for linear mode operation.

### MAXIMUM RATINGS

All Ratings per die:  $T_C = 25^\circ\text{C}$  unless otherwise specified.

Symbol	Parameter	APT94N65B2_LC6	UNIT
$V_{DSS}$	Drain-Source Voltage	650	Volts
$I_D$	Continuous Drain Current @ $T_C = 25^\circ\text{C}$ <sup>1</sup>	95	Amps
	Continuous Drain Current @ $T_C = 100^\circ\text{C}$	61	
$I_{DM}$	Pulsed Drain Current <sup>2</sup>	282	
$V_{GS}$	Gate-Source Voltage Continuous	$\pm 20$	Volts
$P_D$	Total Power Dissipation @ $T_C = 25^\circ\text{C}$	833	Watts
$T_J, T_{STG}$	Operating and Storage Junction Temperature Range	-55 to 150	$^\circ\text{C}$
$T_L$	Lead Temperature: 0.063" from Case for 10 Sec.	260	
$I_{AR}$	Avalanche Current <sup>2</sup>	9.3	Amps
$E_{AR}$	Repetitive Avalanche Energy <sup>3</sup> ( $I_D = 9.3\text{A}, V_{DD} = 50\text{V}$ )	1.76	mJ
$E_{AS}$	Single Pulse Avalanche Energy ( $I_D = 9.3\text{A}, V_{DD} = 50\text{V}$ )	1160	

### STATIC ELECTRICAL CHARACTERISTICS

Symbol	Characteristic / Test Conditions	MIN	TYP	MAX	UNIT
$BV_{(DSS)}$	Drain-Source Breakdown Voltage ( $V_{GS} = 0\text{V}, I_D = 2.0\text{mA}$ )	650			Volts
$R_{DS(on)}$	Drain-Source On-State Resistance <sup>4</sup> ( $V_{GS} = 10\text{V}, I_D = 35.2\text{A}$ )		0.03	0.035	Ohms
$I_{DSS}$	Zero Gate Voltage Drain Current ( $V_{DS} = 650\text{V}, V_{GS} = 0\text{V}$ )		1.0	50	$\mu\text{A}$
	Zero Gate Voltage Drain Current ( $V_{DS} = 650\text{V}, V_{GS} = 0\text{V}, T_C = 150^\circ\text{C}$ )		100		
$I_{GSS}$	Gate-Source Leakage Current ( $V_{GS} = \pm 20\text{V}, V_{DS} = 0\text{V}$ )			$\pm 200$	nA
$V_{GS(th)}$	Gate Threshold Voltage ( $V_{DS} = V_{GS}, I_D = 3.5\text{mA}$ )	2.5	3	3.5	Volts

 CAUTION: These Devices are Sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

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Microsemi Website - <http://www.microsemi.com>



## DYNAMIC CHARACTERISTICS

APT94N65B2\_LC6

Symbol	Characteristic	Test Conditions	MIN	TYP	MAX	UNIT
$C_{iss}$	Input Capacitance	$V_{GS} = 0V$ $V_{DS} = 25V$ $f = 1\text{ MHz}$		8140		pF
$C_{oss}$	Output Capacitance			5451		
$C_{rss}$	Reverse Transfer Capacitance			603		
$Q_g$	Total Gate Charge <sup>⑤</sup>	$V_{GS} = 10V$ $V_{DD} = 300V$ $I_D = 94A @ 25^\circ C$		320		nC
$Q_{gs}$	Gate-Source Charge			50		
$Q_{gd}$	Gate-Drain ("Miller") Charge			168		
$t_{d(on)}$	Turn-on Delay Time	<b>INDUCTIVE SWITCHING</b> $V_{GS} = 15V$ $V_{DD} = 400V$ $I_D = 94A @ 25^\circ C$ $R_G = 4.3\Omega$		26		ns
$t_r$	Rise Time			59		
$t_{d(off)}$	Turn-off Delay Time			323		
$t_f$	Fall Time			172		
$E_{on}$	Turn-on Switching Energy <sup>⑥</sup>	<b>INDUCTIVE SWITCHING @ 25°C</b> $V_{DD} = 400V, V_{GS} = 15V$ $I_D = 94A, R_G = 4.3\Omega$		2916		μJ
$E_{off}$	Turn-off Switching Energy			3257		
$E_{on}$	Turn-on Switching Energy <sup>⑥</sup>	<b>INDUCTIVE SWITCHING @ 125°C</b> $V_{DD} = 400V, V_{GS} = 15V$ $I_D = 94A, R_G = 4.3\Omega$		3947		
$E_{off}$	Turn-off Switching Energy			4034		

## SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

Symbol	Characteristic / Test Conditions	MIN	TYP	MAX	UNIT
$I_S$	Continuous Source Current (Body Diode)			92.6	Amps
$I_{SM}$	Pulsed Source Current <sup>②</sup> (Body Diode)			282	
$V_{SD}$	Diode Forward Voltage <sup>④</sup> ( $V_{GS} = 0V, I_S = -52.4A$ )		0.9	1.2	Volts
$dv/dt$	Peak Diode Recovery $dv/dt$ <sup>⑦</sup>			15	V/ns
$t_{rr}$	Reverse Recovery Time ( $I_S = -94A, di/dt = 100A/\mu s$ )	$T_j = 25^\circ C$		1063	ns
$Q_{rr}$	Reverse Recovery Charge ( $I_S = -94A, di/dt = 100A/\mu s$ )	$T_j = 25^\circ C$		39	μC
$I_{RRM}$	Peak Recovery Current ( $I_S = -94A, di/dt = 100A/\mu s$ )	$T_j = 25^\circ C$		63	Amps

## THERMAL CHARACTERISTICS

Symbol	Characteristic	MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Junction to Case			0.15	°C/W
$R_{\theta JA}$	Junction to Ambient			31	

- Continuous current limited by package lead temperature.
  - Repetitive Rating: Pulse width limited by maximum junction temperature
  - Repetitive avalanche causes additional power losses that can be calculated as  $P_{AV} = E_{AR} \cdot f$ . Pulse width tp limited by  $T_j$  max.
  - Pulse Test: Pulse width < 380 μs, Duty Cycle < 2%
  - See MIL-STD-750 Method 3471
  - Eon includes diode reverse recovery.
  - Maximum diode commutation speed = di/dt 300A/μs
- Microsemi reserves the right to change, without notice, the specifications and information contained herein.

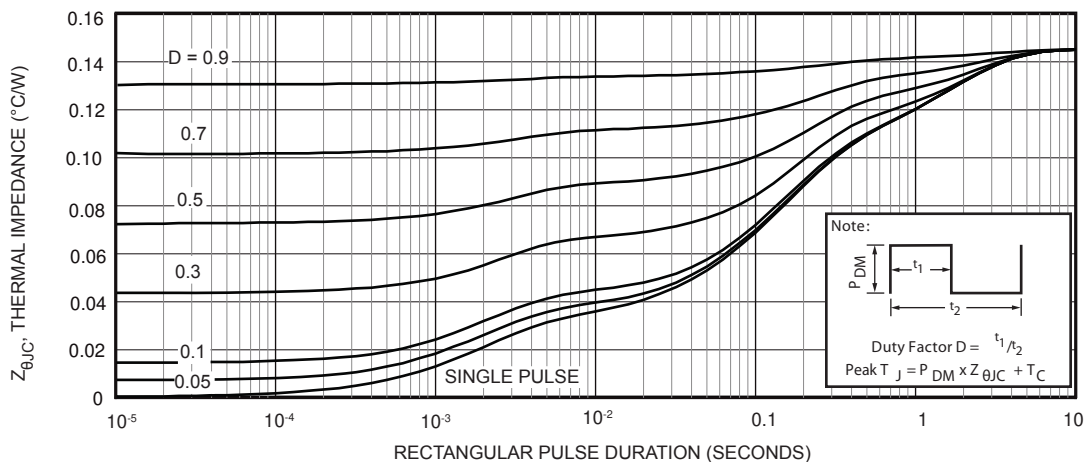


Figure 1, Maximum Effective Transient Thermal Impedance, Junction-To-Case vs Pulse Duration

# Typical Performance Curves

APT94N65B2\_LC6

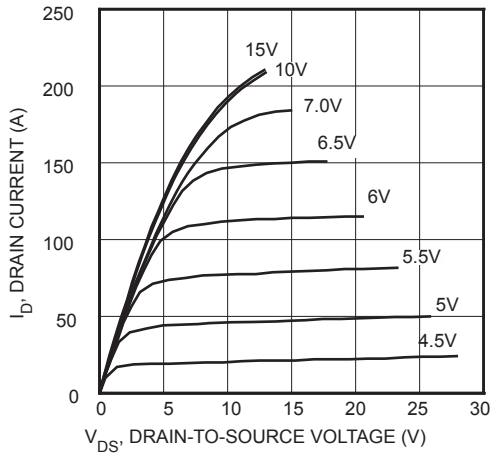


FIGURE 2, Low Voltage Output Characteristics

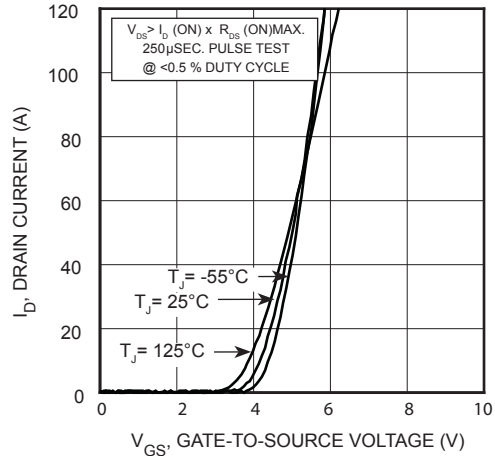


FIGURE 3, Transfer Characteristics

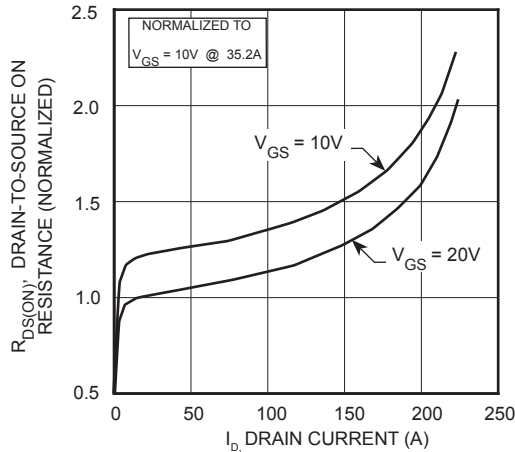


FIGURE 4,  $R_{DS(ON)}$  vs Drain Current

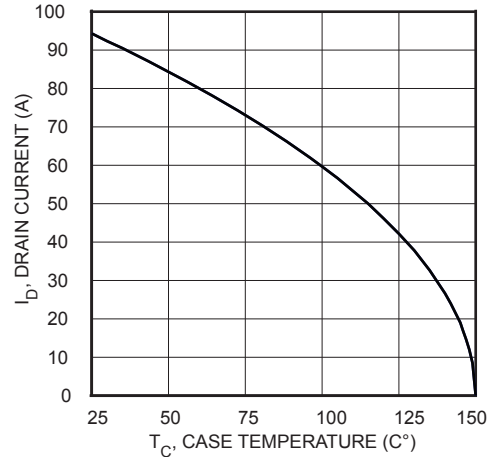


FIGURE 5, Maximum Drain Current vs Case Temperature

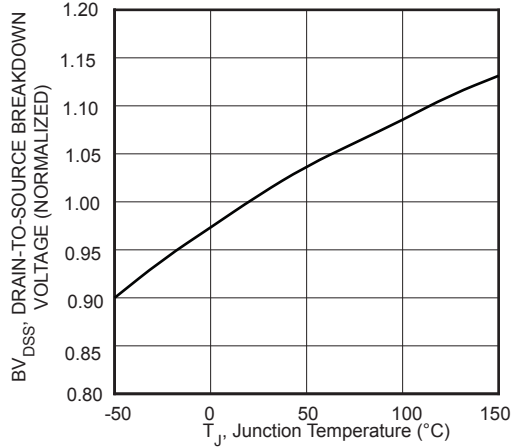


FIGURE 6, Breakdown Voltage vs Temperature

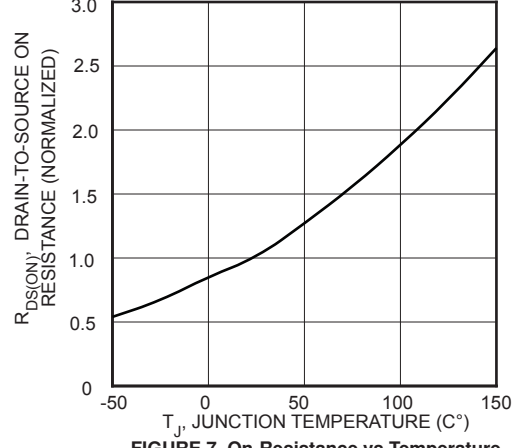


FIGURE 7, On-Resistance vs Temperature

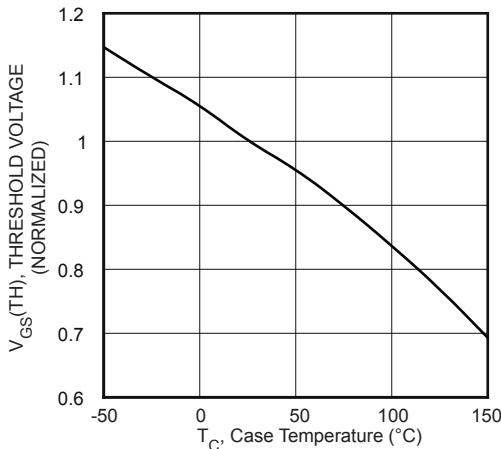


FIGURE 8, Threshold Voltage vs Temperature

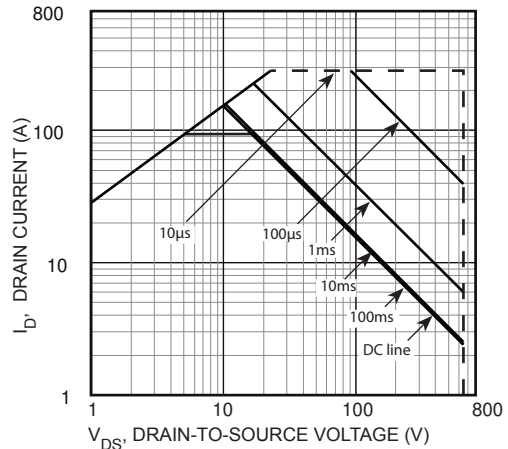


FIGURE 9, Maximum Safe Operating Area

# Typical Performance Curves

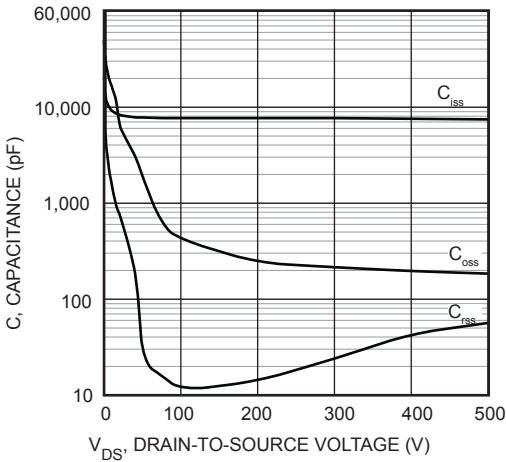


FIGURE 10, Capacitance vs Collector-To-Emitter Voltage

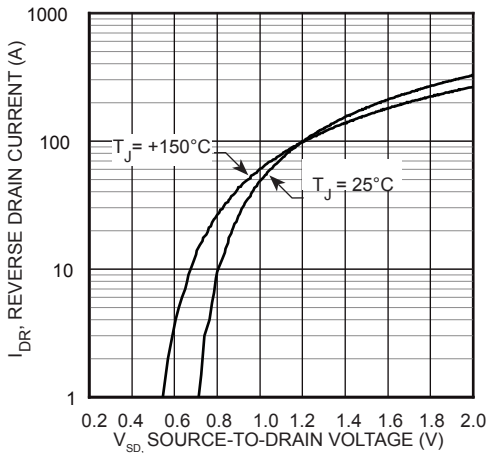


FIGURE 12, Source-Drain Diode Forward Voltage

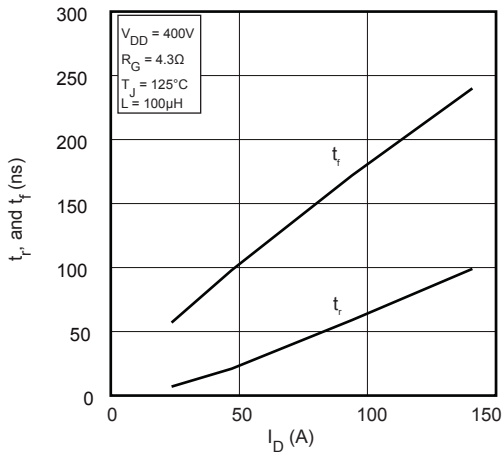


FIGURE 14, Rise and Fall Times vs Current

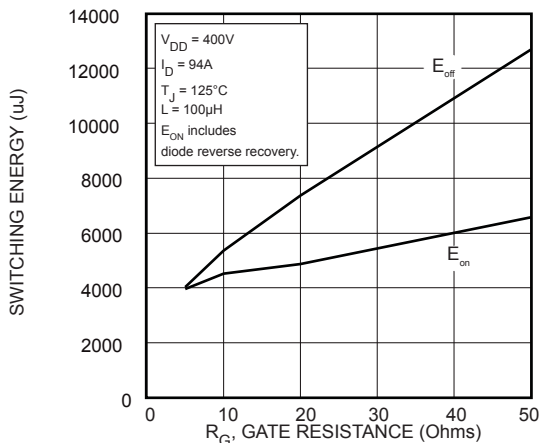


FIGURE 16, Switching Energy vs Gate Resistance

# APT94N65B2\_LC6

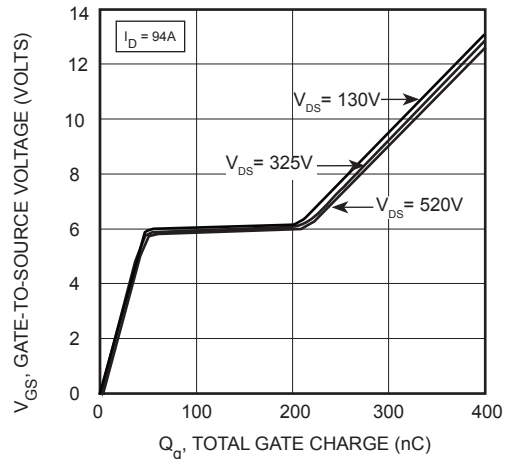


FIGURE 11, Gate Charges vs Gate-To-Source Voltage

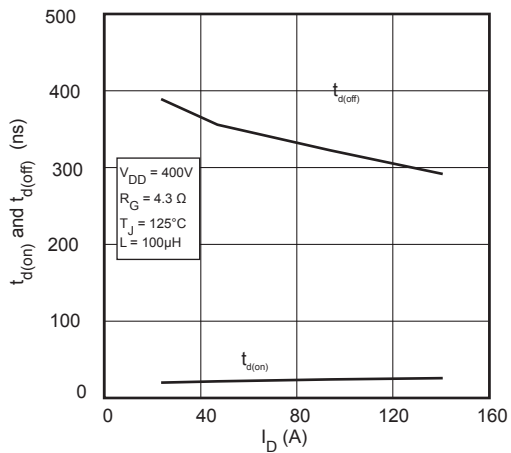


FIGURE 13, Delay Times vs Current

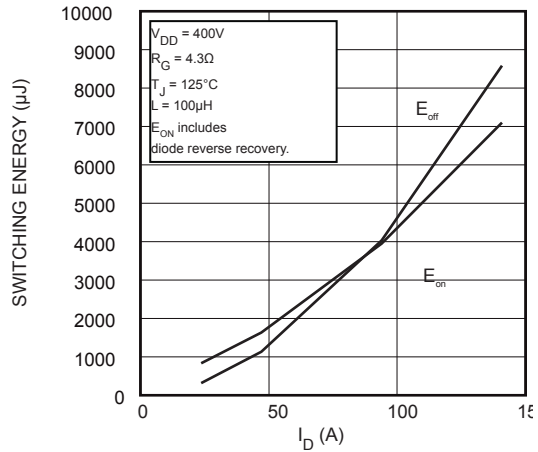


FIGURE 15, Switching Energy vs Current

# Typical Performance Curves

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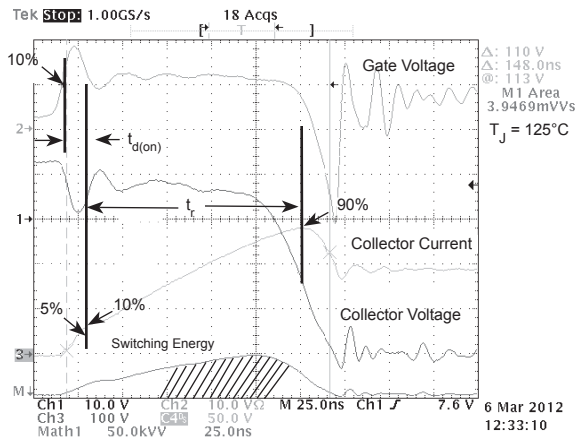


Figure 17, Turn-on Switching Waveforms and Definitions

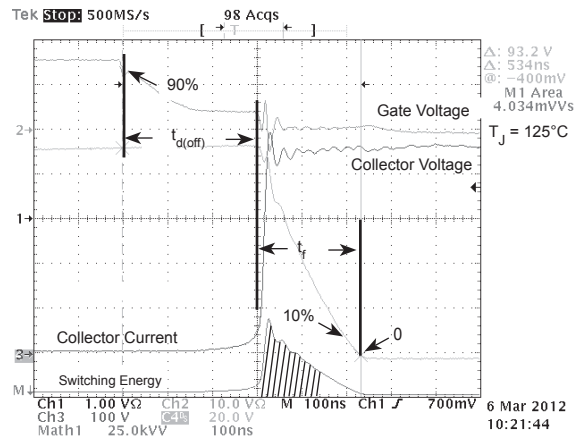


Figure 18, Turn-off Switching Waveforms and Definitions

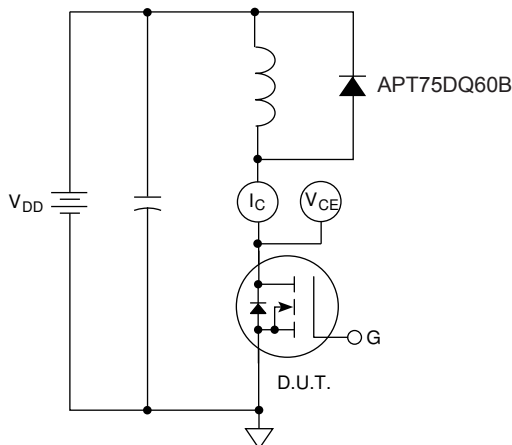


Figure 19, Inductive Switching Test Circuit

## T-MAX® (B2) Package Outline

## TO-264 (L) Package Outline

e3 100% Sn Plated

